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Hole spin resonance and spin-orbit coupling in a silicon metal-oxide-semiconductor field-effect transistor

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We study hole spin resonance in a p-channel silicon metal-oxide-semiconductor field-effect transistor. In the sub-threshold region, the measured source-drain current reveals a double dot in the channel. The observed spin resonance spectra agree with a model of strongly coupled two-spin states in the presence of a spin-orbit-induced anti-crossing. Detailed spectroscopy at the anti-crossing shows a suppressed spin resonance signal due to spin-orbit-induced quantum state mixing. This suppression is also observed for multi-photon spin resonances. Our experimental observations agree with theoretical calculations.

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The silicon-based metal-oxide-semiconductor field-effect transistor (MOSFET) is a key element of large-scale integrated circuits that are at the core of modern technology. Looking into the future, a universal fault-tolerant quantum computer also requires a huge number of physical qubits, on the order of 10⁸ or more [1, 2]. As such, a qubit integrated with the standard Si MOSFET architecture would be truly attractive from the perspectives of scaling up and leveraging existing technologies. One example of such a qubit is the spin of an impulity/defect in the channel of a Si MOSFET. Indeed, spin qubits defined in Si nano-devices are not only compatible with current silicon technology, but are also known to be one of the most quantum coherent among qubit designs [3–14].

There are many studies of impurities and defects in Si [15–17]. Single impurity/defect in the channel of a Si MOSFET has been studied by the telegraph switching of an on-state current [18], and more recently by single electron tunneling [19–23]. Spins of such defects are difficult to characterize because of their weakly-interacting nature. Controlling the spins of impurities in a MOS-FET, as well as in a gate-confined quantum dot, can be achieved much more easily in a p-channel MOSFET than an n-channel. The reason is that the larger spinorbit interaction (SOI) of a hole (-like) spin enables the spin resonance by an oscillatory electric field, instead of a magnetic field, at microwave frequencies under typical sub-Tesla static magnetic fields. Such electrically-driven spin resonance (EDSR) has been demonstrated in III-V devices [24-27], as well as in Si [28-30]. However, systematic investigations of EDSR under the direct influence of SOI have not been performed in Si, the material that

provides an ideal stage for studying SOI due to the minor presence of nuclear spins.

In this work we study sub-threshold transport and EDSR in a short p-channel Si MOSFET, and quantitatively reveal the effects of SOI and EDSR on lifting the spin blockade. Specifically, our transport measurements demonstrate that there are two effective dots in the channel, which allow us to identify a spin blockade regime and explore spin resonance for two stronglycoupled holes. The observed two-spin EDSR spectra, in particular the magnetic field dependence of the resonances, and the associated state mixing provide clear evidence of a SOI-induced anti-crossing with a well-resolved spin-orbit gap. Spectroscopy near the anti-crossing shows a suppressed EDSR signal because the involved states are almost equally populated as a result of the maximum SOI-induced state mixing. Our observations of spin blockade, single- as well as multi-photon spin resonance, and spin-orbit-induced state mixing are important steps toward the precise control of spin qubits in Si MOSFETs.

Our device is a p-channel MOSFET with a channel length of 135 nm and width of 220 nm, as shown in Fig. 1(a). It has a silicon oxynitride gate dielectric, and is fabricated with standard 0.13 μ m CMOS technology. The measurements are performed in a ⁴He pumped cryostat at a temperature of T = 1.6 K. A magnetic field is applied parallel to the MOS interface and the sourcedrain current, and a microwave field is applied directly to the gate electrode. Figure 1(c) shows the measured current in the sub-threshold region. Specifically, we measure the source-drain differential conductance as we vary the source-drain (V_S) and gate (V_G) voltages. A Coulomb diamond with charging energy of 25 meV is observed centered around $V_G = -0.62$ V. The current in this diamond is about three orders of magnitude smaller than the on-state current of the MOSFET, which is a clear evidence of Coulomb blockade. This has been observed in MOSFETs before and attributed to sequential tunneling

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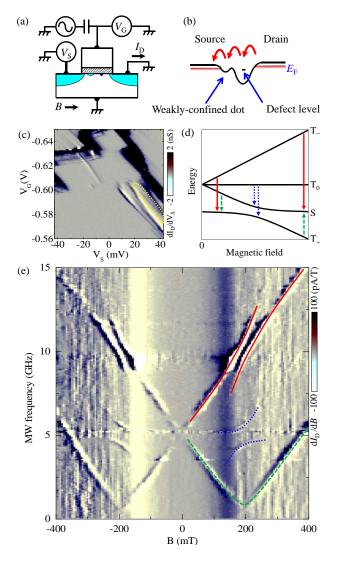


FIG. 1: (a) Schematic of the MOSFET device and measurement set-up. (b) Potential landscape of quantum dots. (c) Intensity plot of dI_D/dV_S near the sub-threshold region. The spin resonance is observed in the region enclosed by the yellow dotted curve. The $dI_D/dV_S=0$ regions for $V_G\approx -0.635$ V are artifacts of the current meter. (d) Schematic energy diagram for two-hole states with a T_+-S anti-crossing due to the spin-orbit interaction. The microwave-induced transitions T_--S (red solid), T_0-S (blue dotted), T_+-S (green dashed) are indicated by vertical arrows. (e) Intensity plot of dI_D/dB measured at $V_S=25$ mV, $V_G=-0.597$ V. For B>0 the high-current EDSR curves due to the transitions T_--S (red solid), T_0-S (blue dotted), T_+-S (green dashed) are indicated. Plotting dI_D/dB suppresses resonances at constant frequency due to photon-assisted tunneling enhanced by cavity modes.

through a single dopant/defect in the channel [19–23].

An important feature of Fig. 1(c), however, is that the Coulomb diamond around $V_G = -0.62$ V does not close all the way to $V_S = 0$ at both its ends near $V_G = -0.60$ V and $V_G = -0.63$ V (this is particularly clear near $V_G = -0.60$ V). This indicates the presence of a larger

dot that is detuned from and coupled in series with a more tightly confined dot, so that sequential tunneling through the double dot can only take place at finite source-drain bias. The data in Fig. 1(c) indicates that the two dots have a weak ($\sim 5~\rm meV)$ and a strong ($\sim 25~\rm meV)$ confinement. The strongly-confined dot could be a Boron dopant in the channel or a dangling bond defect at the silicon/oxynitride interface, whereas the weakly-confined dot could arise from potential fluctuations caused by remote impurities/defects. The physical system can then be represented schematically as shown in Fig. 1(b). Thermal cycles between 1.6 K and 300 K slightly shift the gate voltage dependence, but the Coulomb diamond and the microwave spectroscopy data remain the same after the cycles, indicating the robustness of the double dot.

An interesting regime of double quantum dots is the spin blockade regime, where spin symmetries are correlated with charge configurations [31–33]. In our double dot device, we have evidence of spin blockade. Recall that in the spin blockade [31] transport is blocked if the twospin state is one of the triplet states, T_- , T_0 , or T_+ . Lifting the spin blockade requires cotunneling and/or spin relaxation to the singlet state S that consists of S_{11} and S_{02} components [34]. Specifically, in the area enclosed by the dotted curve in Fig. 1(c), the current is suppressed outside the Coulomb blockade diamond, which indicates that details of the electronic states, such as spin symmetry, prevent electrons from sequential tunneling. Further evidence of spin blockade is revealed when the suppression of conduction is lifted by a microwave applied to the gate electrode, and well-defined current peaks appear depending on both the external magnetic field and the microwave frequency [Fig. 1(e)]. These microwave-induced peaks define the high-current curves seen in Fig. 1(e), and are due to spin excitations that lift the spin blockade which was originally in place. No EDSR was observed on the opposite side of the Coulomb diamond, for $V_S < 0$, mostly because the tunneling is asymmetric for a MOS-FET that is forward- and reverse-biased.

The spectroscopic features of Fig. 1(e) can be qualitatively explained by the low-energy spectrum of two-hole spin states in a double dot [Fig. 1(d)], and also dovetail nicely with the picture of current suppression due to spin blockade. In our double dot there is a singlet-triplet exchange splitting at zero magnetic field due to mixing between the S_{11} and S_{02} singlets [34]. When a finite magnetic field is applied, the triplet states Zeeman-split, with one of the polarized triplets eventually crossing the singlet state. The SOI couples the T_+ triplet with the S_{02} singlet and turns the crossing point into an anti-crossing. The magnitude of the anti-crossing gap is determined by the SOI matrix element between the T_{+} and the S_{02} , and in our device it is about 1 GHz. The two eigenstates near the anti-crossing are mostly mixtures of S_{11} and S_{02} singlets together with the T_{+} triplet. The field at which the anti-crossing occurs, i.e., ± 200 mT in Fig. 1(e), is determined by the zero-field exchange splitting and the q-factors in the two dots.

The high-current curves in Fig. 1(e) can now be attributed to microwave-induced transitions between the mixed singlet-triplet states as indicated by the arrows in Fig. 1(d). Microwave-induced transitions among the triplet states $(T_{\pm} \text{ to } T_0, \text{ i.e. the normal EDSR tran$ sitions) do not lift the spin blockade, thus cannot be observed in our transport experiment. SOI does not couple T_0 and S states, thus we do not observe a horizontal current curve in Fig. 1(e), except near the anticrossing, where the T_0 to T_+ transition is allowed and the spin blockade can be lifted because of the T_{+} -S mixing. Similar EDSR curves have also been observed in III-V nanowire double dots [26]. Notice that, in Fig. 1(e) the background current increases at ± 200 mT, independent of the microwave frequency, giving a clear vertical contrast at these fields. This increase is consistent with the enhanced scattering rate due to the SOI-induced T_{\pm} -S mixing.

The EDSR spectra up to 40 GHz indicate that the q-factor difference between the two dots is small compared with the zero-field singlet-triplet splitting of about 5 GHz [37]. The slope of the current curves in Fig. 1(d) gives an average g-factor for the two dots of 1.80. This is much larger than the value 1.1 observed for Boron dopants in bulk Si [35], while smaller than the value 2.0 of the dangling bond defect centers at the siliconoxynitride interface [36]. We generally expect shallower defects to be more affected by the spin-orbit nature of the valence band, and their q-factors should be smaller than the value of deep dangling bond defects. EDSR spectra as in Fig. 1(e) can be observed throughout the spin blockade area enclosed by the dotted curve in Fig. 1(c). The g-factor does not change significantly in this area, while the exchange energy can change by a factor of 2 depending on V_G . The typical linewidth of EDSR is 0.18 GHz, probably limited by the electrical charge noise due to the strong SOI in our device. We expect only a minor contribution of the nuclear spins to the EDSR linewidth due to the small content (4%) of 29-Si, and the p-orbital nature of holes.

It is emphasized that our experiment is performed at temperature of 1.6 K, which is over an order of magnitude higher than the usual temperatures of 0.1 K reported in previous works [20-26]. Performing the experiment at this high temperature is achieved thanks to the large orbital quantization energy of our dots. This gives also tolerance against unwanted photon-assisted tunneling or pumping current under strong driving.

For a more precise understanding of our observations, we focus on the T_+ –S transition near the anti-crossing point. This anti-crossing has never been observed before; neither in Si nor in III-V quantum dots. Figure 2(a) shows the leakage current (dI_D/dB) as a function of the microwave frequency and the magnetic field. The physics here can be well explained by a two-level model described in Ref. [37]. In brief, we incorporate the microwave driving by assuming that an electric field of amplitude A and frequency $f = \omega/2\pi$ modulates the on-site energy ε_2 of

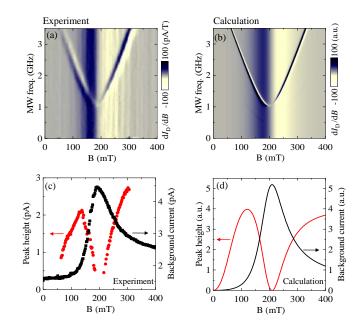


FIG. 2: (a) Measured and (b) calculated spin resonance spectra near the T_+ -S anti-crossing point for weak microwave driving [-40 dBm at the output of the microwave source for (a), and microwave amplitude $A=30~\mu\text{eV}$ for (b)]. Measured (c) and calculated (d) peak height (bright line, left axis), and background current without microwave (dark line, right axis).

dot 2 periodically, namely, $\varepsilon_2 \to \varepsilon_2 + A\cos(\omega t)$. In other words, the transitions we study are purely electrically driven. The model considers the two energy levels E_1 and E_2 which anti-cross. The corresponding eigenstates are $|u_i\rangle = a_i |S_{11}\rangle + b_i |T_+\rangle + c_i |S_{02}\rangle + d_i |T_-\rangle$, i=1,2. The double dot parameters for A=0 are chosen so that the levels anti-cross at about 200 mT, with a spin-orbit gap of about 1 GHz. The coefficients a_i, b_i, c_i , and d_i are obtained by diagonalizing the double dot Hamiltonian in the absence of the microwave. When the microwave is turned on, we perform a unitary transformation into a rotating frame [37], and within a rotating wave approximation we obtain an approximate time-independent Hamiltonian for the single-photon spin resonance

$$h_{\rm DQD} = \begin{pmatrix} E_1 + \hbar\omega/2 & q \\ q & E_2 - \hbar\omega/2 \end{pmatrix}, \tag{1}$$

with

$$q = \hbar \omega \frac{c_1 c_2}{(c_1^2 - c_2^2)} J_1 \left(\frac{A(c_1^2 - c_2^2)}{\hbar \omega} \right), \tag{2}$$

where J_1 is the 1st order Bessel function of the first kind [37]. We then calculate the current with a density matrix approach [37].

The theoretical results from this two-level model, shown in Fig. 2(b), are in good qualitatively agreement with the experimental observations in Fig. 2(a). There are two important features common to both figures, one being the broad peak in the background current (A=0)

centered at about 200 mT independent of the microwave frequency. This peak is the result of the SOI-induced singlet-triplet mixing. It has an asymmetric form [38], unlike the usual symmetric lineshape in a two-level system. The other common feature of Figs. 2(a, b) is the high-current curve due to the microwave-induced T_{+} -S transition. The shape of this curve is hyperbolic, which arises from the normal anti-crossing of two straight lines. The two-level model we adopt here gives us a good qualitative description of the experimental observations. We do not attempt to achieve quantitative agreement because of the missing information with regard to the device, such as the exact interdot tunnel coupling and the microscopic spin-orbit coupling mechanism. For example, differences in the EDSR linewidths between experiment and theory are most probably due to different cotunneling rates that limit the lifetime of spin states in the dots, as well as additional decoherence sources that are not accounted for in the model.

Experimental data in Fig. 2(c) demonstrate that near the anti-crossing at 200 mT the background current reaches a maximum, while the EDSR-induced current has a minimum. This minimum occurs even though the transition rate between the two levels due to the microwave field is the highest because of the maximized singlet-triplet mixing. This interesting feature can be understood within the two-level model. Recall that the leakage current in the spin blockade is due to mixing of the triplet with the singlet state. The microwave field indeed tends to equalize the occupations of the two levels, but near the anti-crossing the SOI already generates the maximum possible singlet-triplet mixing, so that transport of the electrons occupying the T_+ triplet state is no longer blocked. This leads to a maximum in the leakage current, and transitions between the two states due to the microwave field cannot increase the current further. Thus the effect of the microwave is almost completely suppressed. This situation is similar to the well-known saturation of absorption under strong driving in spin resonance experiments [39], where the microwave equalizes the populations of the two levels and eventually leads to a decrease in the resonance signal. Figure 2(d) shows the calculated single-photon EDSR-induced current peak height as well as the background current, which are in nice qualitative agreement with the experimental observations in Fig. 2(c). Notice that while at the T_{+} -S anticrossing the microwave-induced T_{+} -S transition does not lead to further increase in current, the T_0 -S and T_- -S transitions do lead to a current increase because they lift the spin blockade for electrons occupying the T_{-} and T_0 states. In Fig. 1(c), the microwave-induced current increase is visible even at ± 200 mT.

In Fig. 2 the EDSR-induced current peaks also diminish for $B \to 0$ [the feature is also apparent in Fig. 1(e)]. Within the two-level model, when $B \to 0$ the state $|u_2\rangle$ becomes more exclusively the polarized triplet state, $|u_2\rangle \approx |T_+\rangle$, so that the coupling term $q \to 0$ because $c_2 \to 0$. Thus, the microwave field becomes less effi-

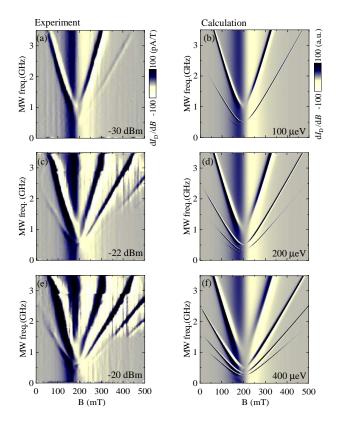


FIG. 3: Measured spin resonance spectra near the T_+ -S anticrossing at higher microwave powers (a) -30 dBm, (c) -22 dBm and (e) -20 dBm at the output of the microwave source respectively. Results of calculation for microwave amplitude (b) $A = 100 \ \mu\text{eV}$, (d) $A = 200 \ \mu\text{eV}$, and (f) $A = 400 \ \mu\text{eV}$.

cient in inducing direct transitions from any of the triplet states to the singlet and the current peaks start to diminish for $B \to 0$. A cautionary note here, however, is that the two-level model becomes increasingly inaccurate as $B \to 0$, because in this limit the triplets become quasi degenerate. In the Supplement [37] we discuss a more accurate calculation based on a Floquet master equation, which confirms the trends observed in Fig. 2.

Multi-photon EDSR has been observed before in double dots at strong microwave driving [40, 41], away from the T_{+} -S anti-crossing. As shown in Figs. 3(a, c, e), when we increase the microwave power in our device we can generate additional current peaks. These peaks correspond to n = 2, 3, or more photons inducing transitions between the two levels that anti-cross. The resulting multi-photon high-current curves are extrapolated to the 1/n of the spin-orbit gap at 200 mT. The multiphoton peaks can be reproduced with the two-level model discussed above when we use the appropriate n-photon Hamiltonian [37]. The theoretical results in Figs. 3(b, d, f) are in good qualitatively agreement with the experiment. Increasing the microwave amplitude A gives rise to extra current peaks, in addition to the primary singlephoton one, corresponding to the successive n-photon

resonance $n\hbar\omega = E_2 - E_1$. Here results up to four-photon transitions are shown [37].

In summary, we studied a p-channel Si MOSFET and identified a spin blockade regime in a double dot system formed by a pair of defects/impurities in the channel. We experimentally observed electrically-driven two-spin resonance and found that the spin-orbit interaction suppresses the spin resonance signal near the anti-crossing point for both single- and multi-photon resonances. Our work shows that impurities/defects in commercial-quality Si MOSFET can be addressed straightforwardly, and they provide a useful window into the electronic spectrum and quantum coherent dynamics.

This revelation is particularly appealing when we consider the great practical advantages that silicon industry could provide to fabricating quantum coherent devices.

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